Search Notes

Application/Control No.	Applicant(s)/Patent un Reexamination	nder
10/724,101	OHMI ET AL.	
Examiner	Art Unit	
Jennifer A. Leung	1764	•

SEARCHED				
Class	Subclass	Date	Examiner	
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Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search. assignee search.	6/22/05	PAL	
su search for parent, 09/773605	6/22/05	DAL	
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